F1-2 PACK SiC MOSFET Module

Product Preview
NXH040P120MNF1PTG, NXH040P120MNF1PG

The NXH040P120MNF1 is a power module containing an 40 mΩ/1200 V SiC MOSFET half bridge and a thermistor in an F1 package.

Features
- 40 mΩ/1200 V SiC MOSFET Half Bridge
- Thermistor
- Options with Pre−applied Thermal Interface Material (TIM) and without Pre−applied TIM
- Press−fit Pins

Typical Applications
- Solar Inverter
- Uninterruptible Power Supplies
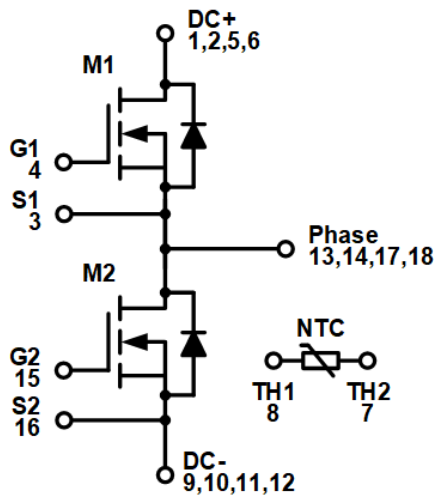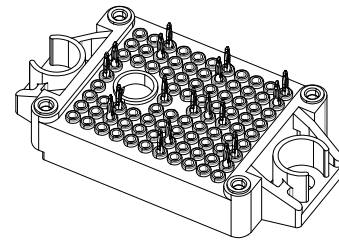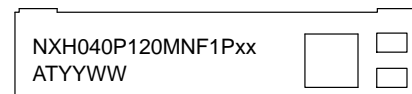- Electric Vehicle Charging Stations
- Industrial Power

PIM18 33.8x42.5 (PRESS FIT)
CASE 180BW

MARKING DIAGRAM

NXH040P120MNF1Pxx
ATYYWW

NXH040P120MNF1PTG= Specific Device Code
NXH040P120MNF1PG = Specific Device Code
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

PIN CONNECTIONS
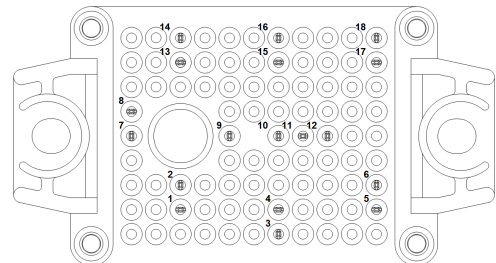
See Pin Function Description for pin names

ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

Figure 1. NXH040P120MNF1 Schematic Diagram

PIN FUNCTION DESCRIPTION

Pin	Name	Description
1	DC+	DC Positive Bus connection
2	DC+	DC Positive Bus connection
3	S1	Q1 Kelvin Emitter (High side switch)
4	G1	Q1 Gate (High side switch)
5	DC+	DC Positive Bus connection
6	DC+	DC Positive Bus connection
7	TH2	Thermistor Connection 2
8	TH1	Thermistor Connection 1
9	DC−	DC Negative Bus connection
10	DC−	DC Negative Bus connection
11	DC−	DC Negative Bus connection
12	DC−	DC Negative Bus connection
13	PHASE	Center point of half bridge
14	PHASE	Center point of half bridge
15	G2	Q2 Gate (Low side switch)
16	S2	Q2 Kelvin Emitter (High side switch)
17	PHASE	Center point of half bridge
18	PHASE	Center point of half bridge

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
SiC MOSFET			
Drain−Source Voltage	V_{DSS}	1200	V
Gate−Source Voltage	V_{GS}	+25/−15	V
Continuous Drain Current @ T_C = 80°C (T_J = 175°C)	I_D	30	A
Pulsed Drain Current (T_J = 175°C)	I_{Dpulse}	90	A
Maximum Power Dissipation (T_J = 175°C)	P_{tot}	74	W
Short Circuit Withstand Time @ V_{GE} = −5V/20 V, V_{CE} = 600 V, $T_J \leq$ 150 °C	T_{sc}	TBD	μs
Minimum Operating Junction Temperature	T_{JMIN}	−40	°C
Maximum Operating Junction Temperature	T_{JMAX}	175	°C
THERMAL PROPERTIES			
Storage Temperature range	T_{stg}	−40 to 150	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 s, 60 Hz	V_{is}	4800	V_{RMS}
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	−40	150	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
SIC MOSFET CHARACTERISTICS						
Drain–Source Breakdown Voltage	V_{GS} = 0 V, I_D = 200 μA	$V_{(BR)DSS}$	1200	–	–	V
Zero Gate Voltage Drain Current	V_{GS} = 0 V, V_{DS} = 1200 V	I_{DSS}	–	–	100	μA
Drain–Source On Resistance	V_{GS} = 20 V, I_D = 25 A, T_J = 25°C	$R_{DS(ON)}$	–	42	56	mΩ
	V_{GS} = 20 V, I_D = 25 A, T_J = 125°C		–	55	–	
	V_{GS} = 20 V, I_D = 25 A, T_J = 150°C		–	61	–	
Gate–Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 10 mA	$V_{GS(TH)}$	1.8	2.81	4.3	V
Gate Leakage Current	V_{GS} = −10/20 V, V_{DS} = 0 V	I_{GSS}	−250	–	250	nA
Internal Gate Resistance		R_G		2.2		Ω
Input Capacitance	V_{DS} = 800 V, V_{GS} = 0 V, f = 1 MHz	C_{ISS}	–	1505	–	pF
Reverse Transfer Capacitance		C_{RSS}	–	12	–	
Output Capacitance		C_{OSS}	–	159	–	
C_{OSS} Stored Energy	V_{DS} = 0 V to 800 V, V_{GS} = 0 V	E_{OSS}	–	66	–	μJ
Total Gate Charge	V_{DS} = 800 V, V_{GS} = 20 V, I_D = 25 A	$Q_{G(TOTAL)}$	–	122.1	–	nC
Gate–Source Charge		Q_{GS}	–	32.2	–	nC
Gate–Drain Charge		Q_{GD}	–	34.7	–	nC
Turn–on Delay Time	T_J = 25°C	$t_{d(on)}$	–	TBD	–	ns
Rise Time	V_{DS} = 600 V, I_D = 25 A	t_r	–	TBD	–	
Turn–off Delay Time	V_{GS} = −5 V/18 V, R_G = TBD Ω	$t_{d(off)}$	–	TBD	–	
Fall Time		t_f	–	TBD	–	
Turn–on Switching Loss per Pulse		E_{ON}	–	TBD	–	mJ
Turn off Switching Loss per Pulse		E_{OFF}	–	TBD	–	
Turn–on Delay Time	T_J = 150°C	$t_{d(on)}$	–	TBD	–	ns
Rise Time	V_{DS} = 6 V, I_D = 25 A	t_r	–	TBD	–	
Turn–off Delay Time	V_{GS} = −5 V/18 V , R_G = TBD Ω	$t_{d(off)}$	–	TBD	–	
Fall Time		t_f	–	TBD	–	
Turn–on Switching Loss per Pulse		E_{ON}	–	TBD	–	mJ
Turn off Switching Loss per Pulse		E_{OFF}	–	TBD	–	
Diode Forward Voltage	I_D = 25 A, T_J = 25°C	V_{SD}	–	3.97	6	V
	I_D = 25 A, T_J = 150°C		–	3.44	–	
Reverse Recovery Time	T_J = 25°C	t_{rr}	–	TBD	–	ns
Reverse Recovery Charge	V_{DS} = 600 V, I_D = 25 A	Q_{rr}	–	TBD	–	nC
Peak Reverse Recovery Current	V_{GS} = −5 V/18 V, R_G = TBD Ω	I_{RRM}	–	TBD	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	TBD	–	A/μs
Reverse Recovery Energy		E_{rr}	–	TBD	–	μJ
Reverse Recovery Time	T_J = 150°C	t_{rr}	–	TBD	–	ns
Reverse Recovery Charge	V_{DS} = 600 V, I_D = 25 A	Q_{rr}	–	TBD	–	μC
Peak Reverse Recovery Current	V_{GS} = −5 V/18 V , R_G = TBD Ω	I_{RRM}	–	TBD	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	TBD	–	A/μs
Reverse Recovery Energy		E_{rr}	–	TBD	–	μJ
Thermal Resistance – chip–to–case	M1, M2	R_{thJC}	–	0.8356	–	°C/W
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 2 Mil _2%, A = 2.8 W/mK	R_{thJH}	–	1.291	–	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
THERMISTOR CHARACTERISTICS						
Nominal resistance	T = 25°C	R_{25}	–	5	–	kΩ
Nominal resistance	T = 100°C	R_{100}	–	457	–	Ω
Deviation of R25		$\Delta R/R$	–3	–	3	%
Power dissipation		P_D	–	50	–	mW
Power dissipation constant			–	5	–	mW/K
B–value	B(25/50), tolerance ±3%		–	3375	–	K
B–value	B(25/100), tolerance ±3%		–	3455	–	K

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH040P120MNF1PG	NXH040P120MNF1PG	F1–2PACK: Case 180BW Press–fit Pins (Pb − Free and Halide − Free)	28 Units / Blister Tray
NXH040P120MNF1PTG	NXH040P120MNF1PTG	F1–2PACK: Case 180BW Press–fit Pins with pre − applied thermal interface material (TIM) (Pb − Free and Halide − Free)	28 Units / Blister Tray

TYPICAL CHARACTERISTICS

SiC MOSFET (M1, M2)

Figure 2. MOSFET Typical Output Characteristics
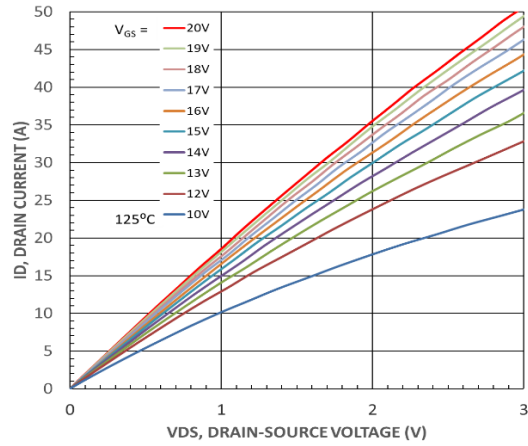
Figure 3. MOSFET Typical Output Characteristics
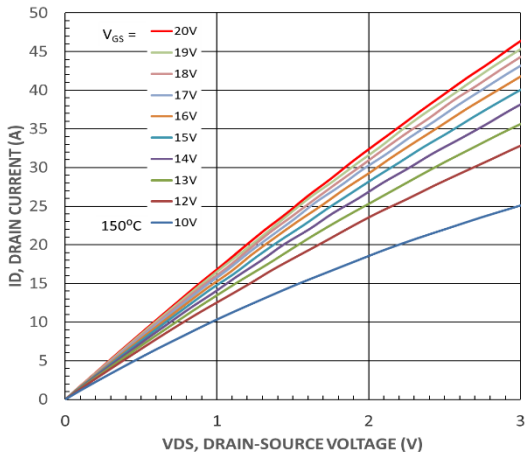
Figure 4. MOSFET Typical Output Characteristics
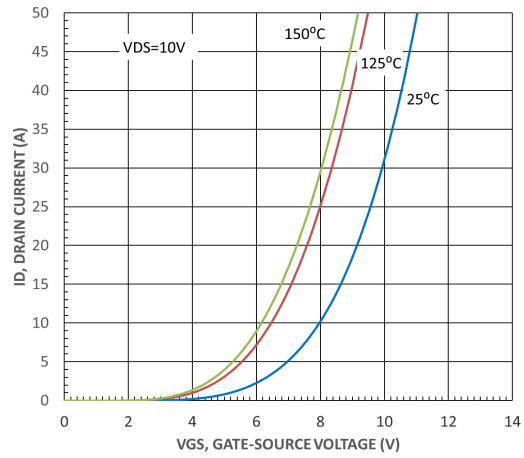
Figure 5. MOSFET Typical Transfer Characteristics
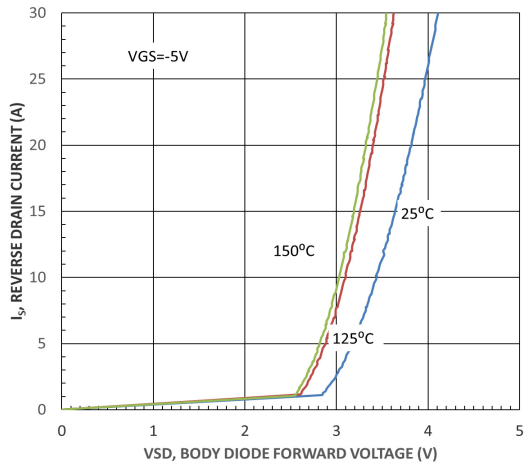
Figure 6. Body Diode Forward Characteristics
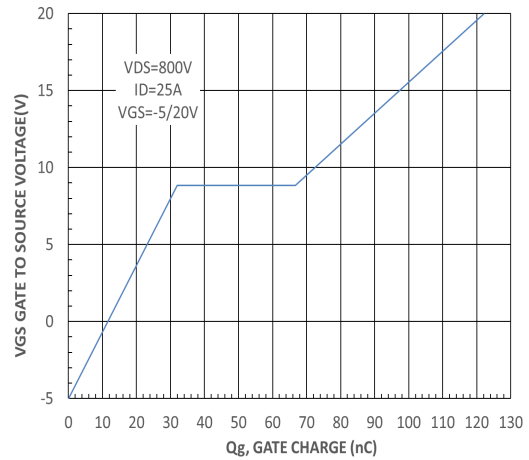
Figure 7. Gate–to–Source Voltage vs. Total Charge

NXH040P120MNF1PTG, NXH040P120MNF1PG

TYPICAL CHARACTERISTICS
SiC MOSFET (M1, M2)
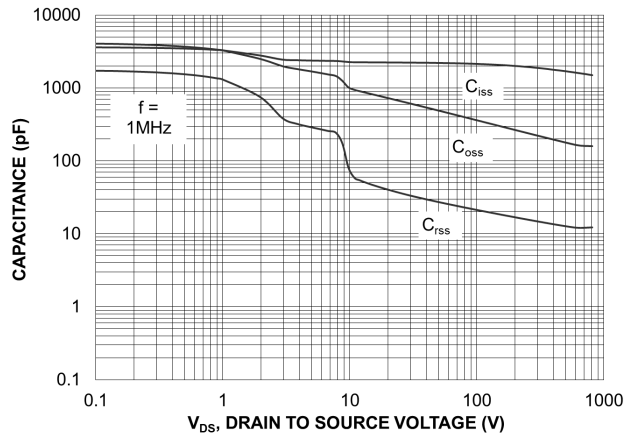
Figure 8. Capacitance vs. Drain−to−Source Voltage
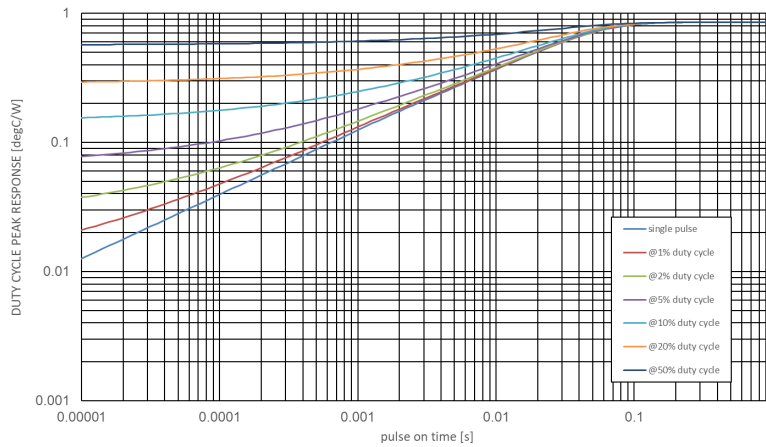
Figure 9. SiC MOSFET Junction−to−Case Transient Thermal Impedance

Table 1. FOSTER NETWORKS – M1, M2

Foster Element #	M1		M2	
	Rth (K/W)	Cth (Ws/K)	Rth (K/W)	Cth (Ws/K)
1	0.051996	0.002404	0.054881	0.002284
2	0.046504	0.020373	0.010554	0.082427
3	0.008903	0.221087	0.064895	0.028973
4	0.165341	0.039489	0.094862	0.058574
5	0.600991	0.065660	0.610507	0.052914

Table 2. CAUER NETWORKS – M1, M2

Cauer Element #	M1		M2	
	Rth (K/W)	Cth (Ws/K)	Rth (K/W)	Cth (Ws/K)
1	0.076857	0.001961	0.076754	0.001921
2	0.141063	0.010485	0.182594	0.011596
3	0.274014	0.018050	0.136313	0.018196
4	0.113973	0.038620	0.215815	0.019717
5	0.267827	0.046224	0.224225	0.049799

PIM18 33.8x42.5 (PRESS FIT)
CASE 180BW
ISSUE B

DATE 30 APR 2021

PACKAGE MARKING LOCATION

SIDE VIEW

D

E   E1 E2 E3

E4

D1   φP

D2

TOP VIEW
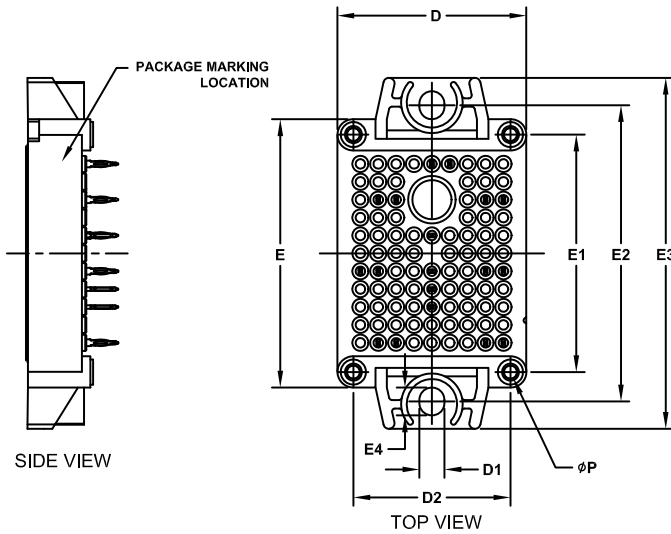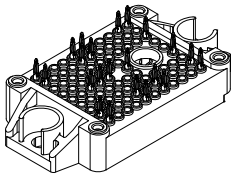
NOTES:
1. CONTROLLING DIMENSION: MILLIMETERS
2. PIN POSITION TOLERANCE IS ± 0.4mm

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	11.65	12.00	12.35
A1	16.00	16.50	17.00
A2	0.00	0.35	0.60
A3	12.85	13.35	13.85
b	1.15	1.20	1.25
b1	0.59	0.64	0.69
D	33.50	33.80	34.10
D1	4.40	4.50	4.60
D2	27.95	28.10	28.25
E	47.70	48.00	48.30
E1	42.35	42.50	42.65
E2	52.90	53.00	53.10
E3	62.30	62.80	63.30
E4	4.90	5.00	5.10
P	2.20	2.30	2.40

b   b1

A3   A   A1

A2

END VIEW
DBC EXPOSAL

14.05   14.05
12.8   12.8
9.6   9.6
6.4   3.2

27.0
21.3
27.0
21.3

3.2
9.6   16.0
6.4
9.6   16.0
3.2

φ2.8
φ9.0

φ0.94~1.09
PLATED
THRU HOLE

**RECOMMENDED
MOUNTING PATTERN**
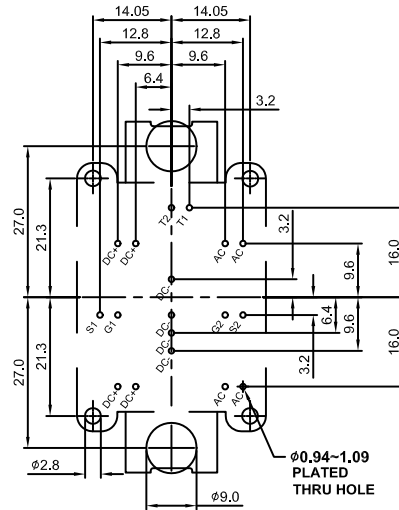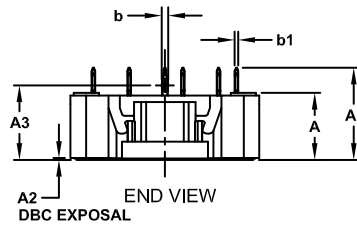
**GENERIC
MARKING DIAGRAM***

XXXXXXXXXXXXXXXXXXXXXX
ATYYWW
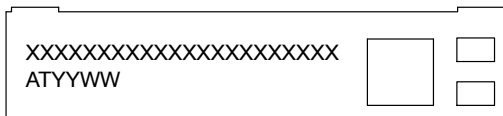
XXXXX = Specific Device Code
AT   = Assembly & Test Site Code
YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot " ▪ ", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	PIM18 33.8x42.5 (PRESS FIT)		PAGE 1 OF 1

PUBLICATION ORDERING INFORMATION

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